

<b>Notice of References Cited</b>	Application/Control No. 10/625,201		Applicant(s)/Patent Under Reexamination DAVIS ET AL.	
	Examiner John B. Strege		Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0081346	04-2004	Louden et al.	382/141
*	B	US-6,636,634	10-2003	Melikian et al.	382/217
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	Q					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Shi et al., Normalized Cuts and Image Segmentation, August 2000, IEEE Transactions on pattern analysis and machine intelligence, vol. 22, no. 8, pages 888-905.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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